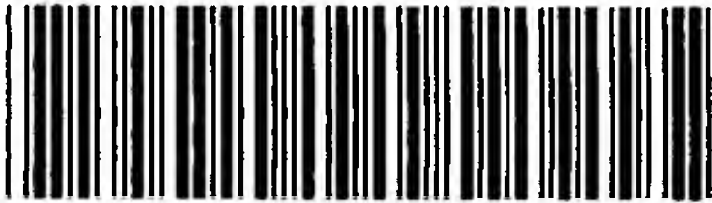


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/599,429	IIYOSHI ET AL.	
	Examiner	Art Unit	
	Eileen P. Morgan	3723	

SEARCHED			
Class	Subclass	Date	Examiner
451	443 548		
		9/11/2007	EPM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR